Selective Fabrication of Monolayer 1*H*- and 1*T*'-WTe₂

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> We selectively fabricated monolayers of octahedral (1H) and distorted trigonal (1T') WTe₂ on graphene/SiC(0001) by controlling the substrate temperature during epitaxy. Angle-resolved photoemission spectroscopy, combined with first-principles bandstructure calculations, has revealed several drastic differences between these two polymorphs. The 1T' phase exhibits a semiconducting character with a nearly-zero energy gap, while the 1H phase shows a large band gap and the band splitting at the K/K' point. The present results pave a pathway toward developing nanoelectronic devices based with WTe₂.

Layered transition metal dichalcogenides (TMDs) exhibit a variety of novel quantum phenomena such as superconductivity, charge-density wave, and metal-insulator transition, depending on the constituent element and the crystal symmetry.¹⁾ TMDs generally take two different types of stable structures; one is 2H with a triangular prismatic structure stacked with a two-fold periodicity, and the other is 1T with an octahedral structure. It is also known that bulk TMDs containing the group-VI transition metal such as Mo and W take some additional crystal structures different from 2H and 1T when the growth condition is well controlled. This is highlighted by realization of 1T²-MoTe₂ upon local heating of bulk 2H-MoTe₂ crystal, leading to an ohmic homojunction with a very high mobility.²⁾

Here we focus on WTe₂ having two stable structures in bulk, 2H and T_d .³⁾ The latter takes

an orthorhombic structure with distorted octahedral 1T' layers stacked alternately with 180° rotation.⁴⁾ Bulk 2*H*-WTe₂ is an indirect semiconductor⁵⁾ whereas the monolayer counterpart (1*H*) is predicted to be a direct-gap semiconductor with a spin-split band structure at the K/K' point in the Brillouin zone (BZ) due to the strong spin-orbit coupling (SOC) and the space-inversion-symmetry (SIS) breaking.⁶⁾ The SIS breaking in monolayer 1*H* phase is known to play an essential role in realizing various exotic properties such as circular-light-polarization-dependent photoluminescence⁷⁾ and Ising superconductivity⁸⁾ in pristine monolayer and carrier-doped monolayer 1*H*-MoS₂, respectively. On the other hand, bulk *T*_d-WTe₂ is a Weyl semimetal with surface Fermi-arc states,^{9,10)} whereas the monolayer counterpart (1*T*'-WTe₂) is a candidate of two-dimensional topological insulator (2D TI),¹¹⁾ as supported by the observation of edge states in the transport and scanning-tunneling-microscopy (STM) measurements.^{12,13)} While it is important to establish a method to selectively fabricate various crystal phases in order to further functionalize the W-based TMDs, this has yet to be established for monolayer WTe₂.

In this work, we have succeeded in selectively fabricating 1H and 1T' monolayers of WTe₂ by precisely controlling the substrate temperature (T_s) during the molecular-beam epitaxy (MBE), and characterized the band structure using ARPES and DFT (density-functional-theory) calculations.

Monolayer WTe₂ was grown on bilayer graphene.¹⁴⁻¹⁶⁾ At first, bilayer graphene was fabricated by resistive heating of an *n*-type 4H-SiC(0001) single-crystal wafer at 1100 °C for 15 min under high vacuum better than 1.0×10^{-9} Torr. Subsequently, a monolayer WTe₂ film was grown by evaporating W atoms on the bilayer graphene substrate in Te-rich atmosphere. We optimized the growth condition by systematically changing T_s during the epitaxial growth, and found that the optimum T_s value to grow 1H and 1T' films is 280 °C and 310 °C, respectively [see Fig. 1(a)]. To improve the crystallinity, as-grown monolayer WTe₂ films were annealed for 30 min at the same T_s . In-situ ARPES measurements were carried out using an MBS-A1 electron analyzer with a He discharge lamp (photon energy hv = 21.218 eV) at Tohoku University and a DA-30 electron analyzer (Omicron-Scienta) at beamline BL-28A in Photon Factory, KEK. The energy and angular resolutions were set to be 16 meV and 0.2°, respectively. DFT calculations were carried out by using the QUANTUM-ESPRESSO package¹⁷) with generalized gradient approximation¹⁸⁾ and also with Heyd-Scuseria-Ernzerhof (HSE06) hybrid functional. The plane-wave cutoff energy and uniform k-point mesh were set to be 60 Ry and 10×5×1, respectively. The thickness of inserted vacuum layer was more than 10 Å to prevent interlayer interaction. SOC was included in the calculation.

We show in Fig. 1(b) the plot of ARPES intensity at T = 40 K for monolayer WTe₂ fabricated

at $T_s = 280$ °C, measured along the Γ K cut of graphene BZ. Figure 1(d) shows the corresponding energy distribution curve (EDC) at the Γ point. One can recognize several key features such as (i) suppression of ARPES intensity in the binding-energy (E_B) range of Fermi level (E_F) -0.5 eV indicative of the semiconducting nature, (ii) a hole band topped at $E_{\rm B} \sim 1.3$ eV at the Γ point which rapidly moves toward higher $E_{\rm B}$ on moving away from the Γ point, and (iii) broad intensity at $E_{\rm B} \sim 0.5$ -1 eV around the K point. These key features are reproduced well in the DFT calculations including SOC for free-standing monolayer 1H-WTe₂ (red curves), suggesting that the monolayer fabricated at $T_s = 280$ °C has the 1*H* phase. On the other hand, in the monolayer fabricated at $T_s = 310 \text{ °C}$ [Fig. 1(c, e)], one can identify an obvious difference; four hole bands topped at $E_{\rm B} \sim 0.1, 0.6, 0.8$, and 1.3 eV are observed at the Γ point. They are reasonably reproduced by the DFT calculations with HSE06 (red curves) for free-standing monolayer 1T'-WTe₂, consistent with the previous study¹⁵ (note that the temperature evolution of the band structure in the 1T' phase is reported in a separate work¹⁶). These results indicate that monolayer 1H and 1T'-WTe₂ phases can be selectively fabricated by fine-tuning T_s during the MBE growth. This conclusion is supported by the Te 4d core-level spectrum. While each Te $4d_{3/2}$ and $4d_{5/2}$ spin-orbit satellite is composed of a single peak in the 1*H* phase [see Fig. 1(f)], a two-peaked structure is identified for the 1T' phase [Fig. 1(g)]. This is because the 1H phase has a single W-Te bond length whereas the 1T phase has two types of bond lengths due to the distorted structure¹⁹⁾, as shown in Fig. 1(a). It is noted here that the electron diffraction experiment does not work well to distinguish the two-fold-symmetric 1T' phase because of the inevitable mixture of three domains rotated by 120° from each other due to symmetry mismatch with the graphene substrate with six-fold symmetry, as reported in 1T-WTe₂¹⁵⁾ and other TMDs¹⁹). To resolve the band structure of each domain, nano-ARPES measurement is necessary.

Now we examine the band structure of 1*H* phase in more detail. It is theoretically predicted that the band structure of 1*H* phase shows a spin-valley coupling at the K/K' point [inset to Fig. 2(a)],^{6,14)} causing the spin splitting due to the SIS breaking and the strong SOC. We show in Fig. 2(a) the second-derivative intensity of ARPES spectrum, compared with the DFT calculation at $E_B = 0.4$ -1.7 eV where the band splitting is expected to occur around the K/K' point. In the DFT calculation, we identify the spin-split partners topped at $E_B = 0.7$ and 1.2 eV, respectively, which look to show a reasonable agreement with the experiment despite the broad ARPES intensity. To further examine the band splitting, we show in Fig. 2(b) the energy distribution curve (EDC) at the K point. The EDC consists of a peak at ~1.5 eV accompanied by a shoulder-like feature at ~1 eV. These features are well reproduced by numerical simulations

by assuming two peaks with a moderate background. This suggests the existence of a band splitting of ~0.5 eV at the K point in monolayer 1H-WTe₂.

It is emphasized here that the success of selective fabrication of 1H- and 1T'-WTe₂ is an important step to realize several exotic quantum phenomena as well as for device applications. Monolayer 1T'-WTe₂ would be used in 2D-TI-based devices where the band inversion and resultant spin current are controlled by an external electronic field. Monolayer 1H-WTe₂ is expected to serve as a useful platform to realize various exotic spin-valley-coupled phenomena such as the spin- or valley-Hall effect induced by circularly polarized light.⁶ In addition, a lateral heterostructure consisting of 1T'- and 1H-WTe₂ would be used to generate chiral spin-currents at the topological edge by injecting spin-polarized carriers across the 1H-1T' interface.

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FIG. 1 (Color online). (a) Schematics of selective fabrication of 1*H*- and 1*T*'-WTe₂ monolayers by controlling the substrate temperature T_s . (b), (c) ARPES intensity plotted as a function of wave vector and binding energy for 1*H*- and 1*T*'-WTe₂ monolayers, respectively, measured along the Γ K cut of graphene BZ with hv = 21.218 eV. Inset shows the first BZ of graphene (white line), 1*H*- (red line), and 1*T*'- (blue line) WTe₂. Corresponding DFT calculations for free-standing WTe₂ are overlaid for comparison. Calculations for 1*H* and 1*T*' phases were carried out with GGA and HSE06, respectively. (d), (e) EDC at the Γ point for 1*H*- and 1*T*'- WTe₂, respectively. (f), (g) Te 4*d* core-level spectrum for 1*H*- and 1*T*'- WTe₂, respectively, measured at *T* = 40 K with hv = 80 eV. Peak positions are marked by vertical lines. While the GGA calculation overall reproduces the experimental valence-band structure for both the 1*H* and 1*T*' phases, it was necessary to use HSE06 for the 1*T*' phase to reproduce the narrow band gap around *E*_F.



FIG. 2 (Color online). (a) Plot of second derivative intensity of ARPES spectrum for monolayer 1H-WTe₂, compared with the calculated band structure. Inset shows the schematic of spin-valley-coupled band structure around the K/K' point. (b) EDC at the K point and the result of numerical simulation (black curve) that assumes two Lorentzians (blue and green curves) with a moderate background (purple curve) multiplied by the Fermi-Dirac distribution function convoluted with the resolution function.